April 2001

SEMICONDUCTOR M

FAIRCHILD

30V N-Channel PowerTrench[®] MOSFET

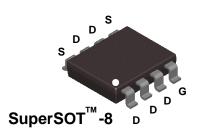
General Description

FDR6674A

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for "low side" synchronous rectifier operation, providing an extremely low $R_{DS(ON)}$ in a small package.

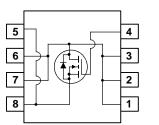
Applications

- Synchronous rectifier
- DC/DC converter





- 11.5 A, 30 V. $R_{DS(ON)} = 9.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$ $R_{DS(ON)} = 8.5 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability in a smaller footprint than SO8



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units	
V _{DSS}	Drain-Source Voltage		30		
V _{GSS}	Gate-Source Voltage		±12		
I _D	Drain Current – Continuous	(Note 1a)	11.5	A	
	– Pulsed		50		
PD	Power Dissipation for Single Operati	ON (Note 1a)	1.8	W	
		(Note 1b)	1.0		
		(Note 1c)	0.9		
- -	Operating and Starage Junction Ten	an anatura Dan na	-55 to +150		
T _J , T _{STG}	Operating and Storage Junction Ten	nperature Range	-55 t0 +150	°C	
Therma	I Characteristics	· · · ·			
Therma R _{eja}	I Characteristics Thermal Resistance, Junction-to-Am	bient (Note 1a)	70	°C/W	
	I Characteristics	bient (Note 1a)		°C/W	
Therma R _{θJA} R _{θJC}	I Characteristics Thermal Resistance, Junction-to-Am	bient (Note 1a) Se (Note 1)	70	°C/W	
Therma R _{eJA} R _{eJC} Packag	I Characteristics Thermal Resistance, Junction-to-Am Thermal Resistance, Junction-to-Cas	bient (Note 1a) Se (Note 1)	70		

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		l			
BV _{DSS}	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$, $I_D = 250 \mu A$	30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 V, V_{GS} = 0 V$			1	μA
I _{GSSF}	Gate-Body Leakage, Forward	$V_{GS} = 12 V, V_{DS} = 0 V$			100	nA
IGSSR	Gate-Body Leakage, Reverse	$V_{GS} = -12 \text{ V}$, $V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	0.8	1.2	2	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		-4		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{GS} = 4.5 \ V, \ I_D = 10.5 \ A \\ V_{GS} = 4.5 \ V, \ I_D = 10.5 \ A, \ T_J \ 125^\circ C \\ V_{GS} = 10 \ V, \ I_D = 11.5 \ A \end{array} $		8.2 11.5 6.8	9.5 16 8	mΩ
I _{D(on)}	On–State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	50			А
g fs	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_D = 11.5 \text{ A}$		75		S
Dynamic	c Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 15 V, V_{GS} = 0 V,$		5070		pF
Coss	Output Capacitance	f = 1.0 MHz		550		pF
C _{rss}	Reverse Transfer Capacitance			230		pF
Switchin	ng Characteristics (Note 2)					
t _{d(on)}	Turn–On Delay Time	$V_{DD} = 10 V, I_D = 1 A,$		17	25	ns
tr	Turn–On Rise Time	$V_{GS} = 4.5 V, R_{GEN} = 6 \Omega$		18	25	ns
t _{d(off)}	Turn–Off Delay Time	7		69	100	ns
t _f	Turn–Off Fall Time			29	42	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$, $I_D = 11.5 A$,		33	46	nC
Q _{gs}	Gate-Source Charge	$V_{GS} = 4.5V$		7.5		nC
Q _{gd}	Gate–Drain Charge			6.8		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				2.1	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$, $I_S = 2.1 A$ (Note 2)		0.7	1.2	V

1. R_{6JA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.

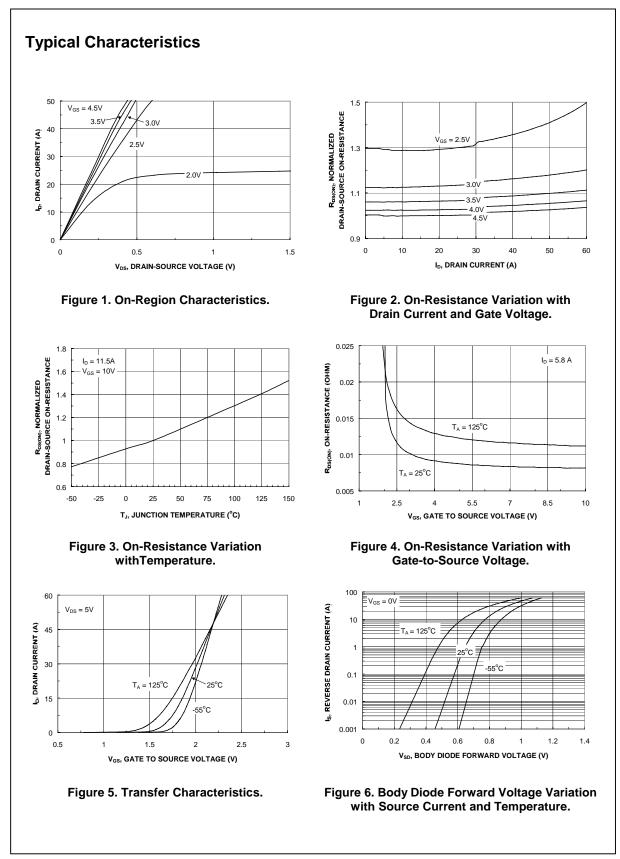


a) 70°/W when mounted on a 1in² pad of 2 oz copper b) 125°/W when mounted on a .04 in² pad of 2 oz copper

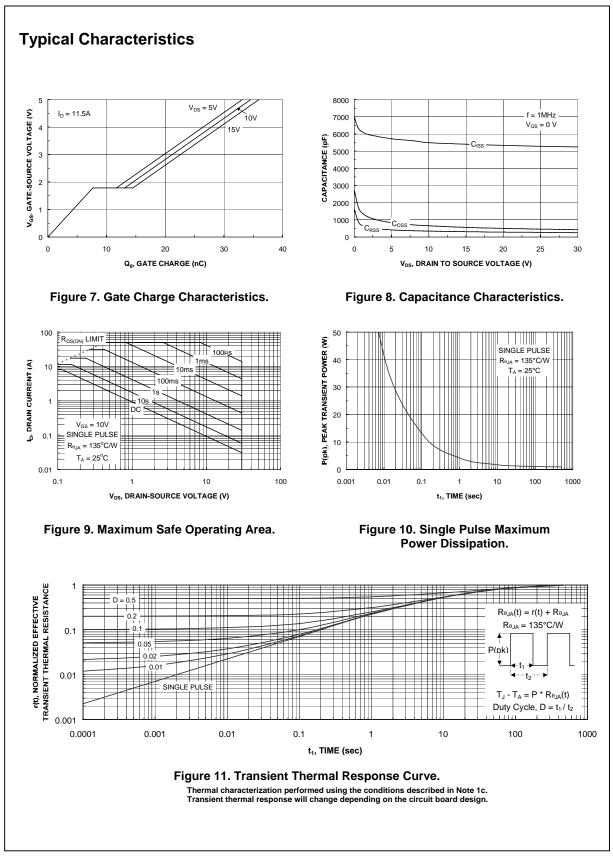
c) 135°/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%

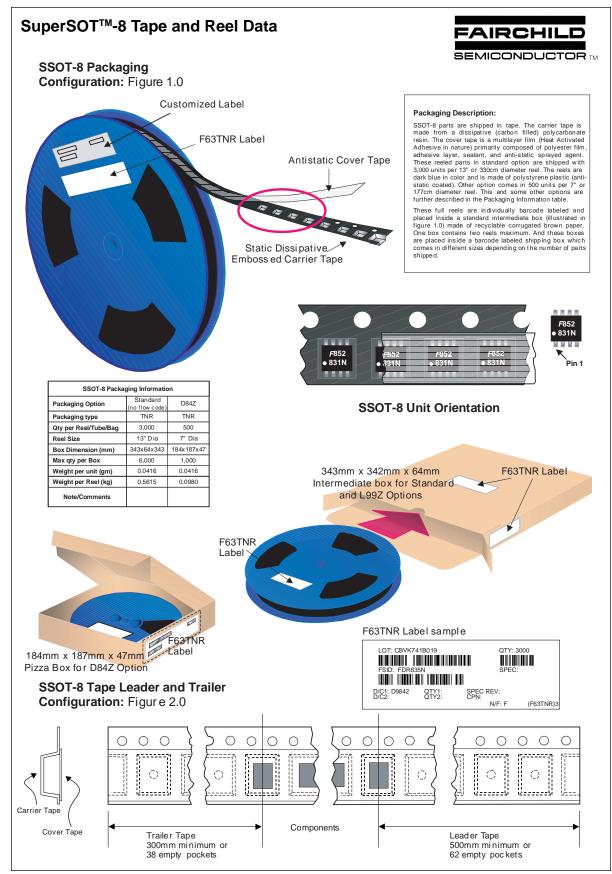


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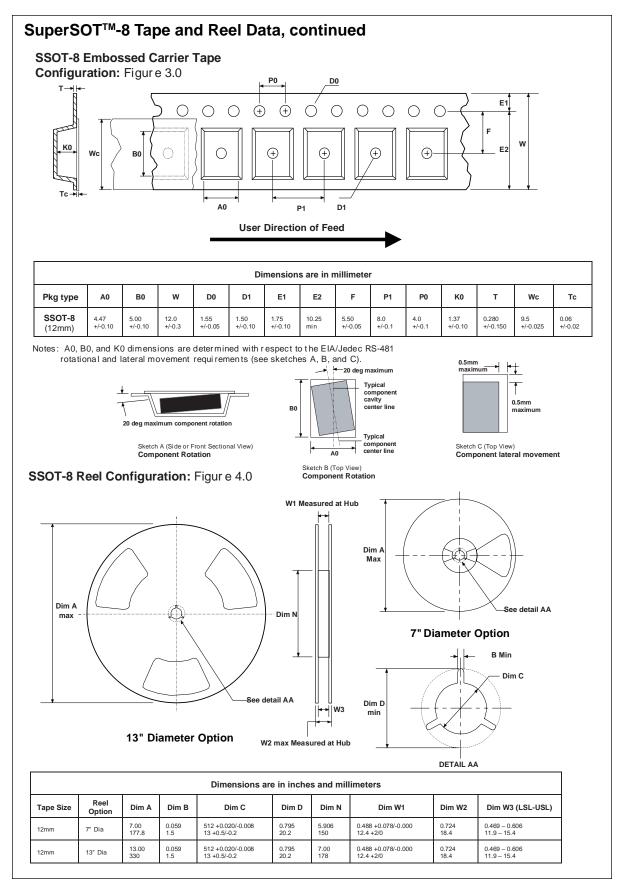
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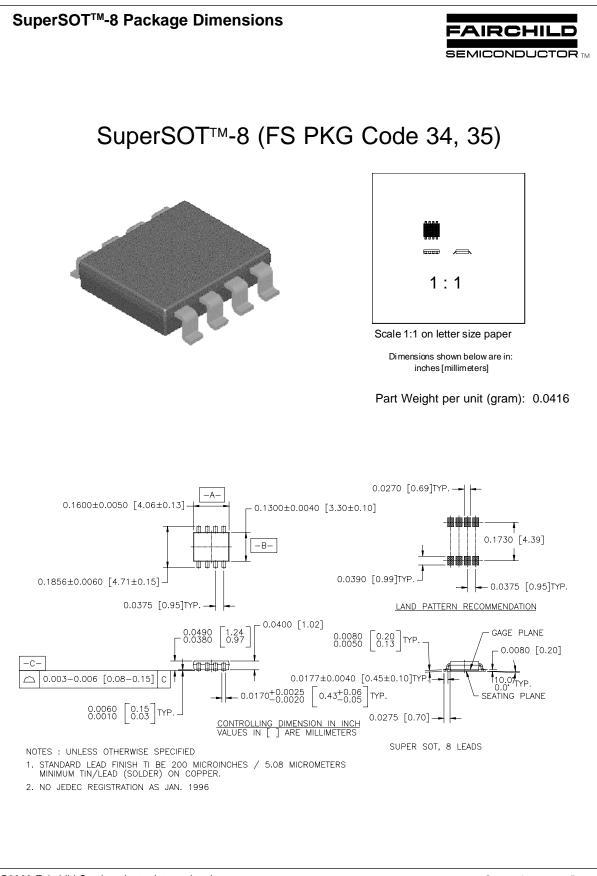


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